

PH3230

N-channel enhancement mode field-effect transistor

Rev. 01 — 7 February 2002

Product data

1. Description

The latest generation N-channel enhancement mode field-effect power transistor in a SOT669 (LFAK) package.

Product availability:

PH3230 in SOT669 (LFAK)

2. Features

- Logic level compatible
- Low drive current
- High density mounting
- Very low on-state resistance.

3. Applications

- DC to DC converter
- Computer motherboards
- Switch mode power supplies.

4. Pinning information

Table 1: Pinning - SOT669 (LFAK), simplified outline and symbol

Pin	Description	Simplified outline	Symbol
1,2,3	source (s)	<p>Top view MBL286</p> <p>SOT669 (LFAK)</p>	<p>MBL288</p>
4	gate (g)		
5	drain (d)		



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5. Quick reference data

Table 2: Quick reference data

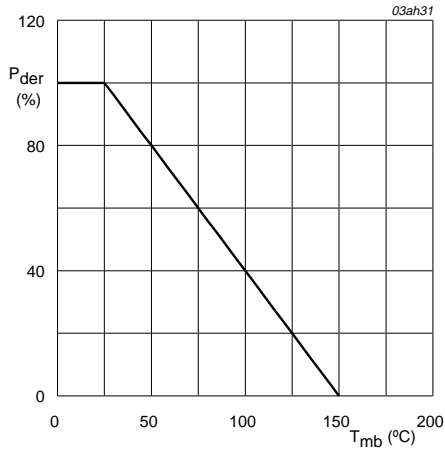
Symbol	Parameter	Conditions	Typ	Max	Unit
V_{DS}	drain-source voltage (DC)	$T_j = 25\text{ °C}$	-	30	V
I_D	drain current (DC)	$T_{mb} = 25\text{ °C}$	-	50	A
P_{tot}	total power dissipation	$T_{mb} = 25\text{ °C}$	-	42	W
T_j	junction temperature		-	150	°C
R_{DSon}	drain-source on-state resistance	$V_{GS} = 10\text{ V}; I_D = 25\text{ A}; T_j = 25\text{ °C}$	3.2	3.7	mΩ
		$V_{GS} = 4.5\text{ V}; I_D = 25\text{ A}; T_j = 25\text{ °C}$	5.5	7.3	mΩ

6. Limiting values

Table 3: Limiting values

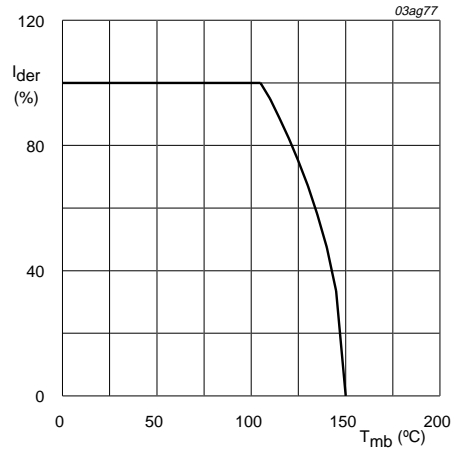
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage (DC)	$T_j = 25\text{ to }150\text{ °C}$	-	30	V
V_{GS}	gate-source voltage (DC)		-	±20	V
I_D	drain current (DC)	$V_{GS} = 10\text{ V}; T_{mb} = 25\text{ °C};$ Figure 2 and 3	-	50	A
I_{DM}	peak drain current	$T_{mb} = 25\text{ °C};$ pulsed; $t_p \leq 10\text{ }\mu\text{s};$ Figure 3	-	200	A
P_{tot}	total power dissipation	$T_{mb} = 25\text{ °C};$ Figure 1	-	42	W
T_{stg}	storage temperature		-55	+150	°C
T_j	operating junction temperature		-55	+150	°C
Source-drain diode					
I_{SM}	peak source (diode forward) current	$T_{mb} = 25\text{ °C};$ pulsed; $t_p \leq 10\text{ }\mu\text{s}$	-	50	A



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

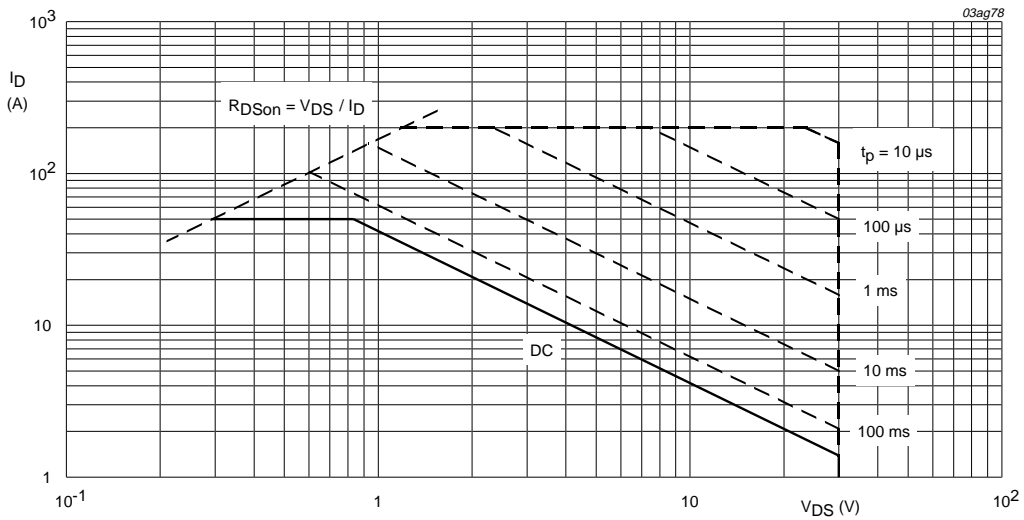
Fig 1. Normalized total power dissipation as a function of mounting base temperature.



V_{GS} ≥ 10 V

$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature.



T_{mb} = 25 °C; I_{DM} is single pulse.

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

7. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	Figure 4	-	-	3	K/W

7.1 Transient thermal impedance

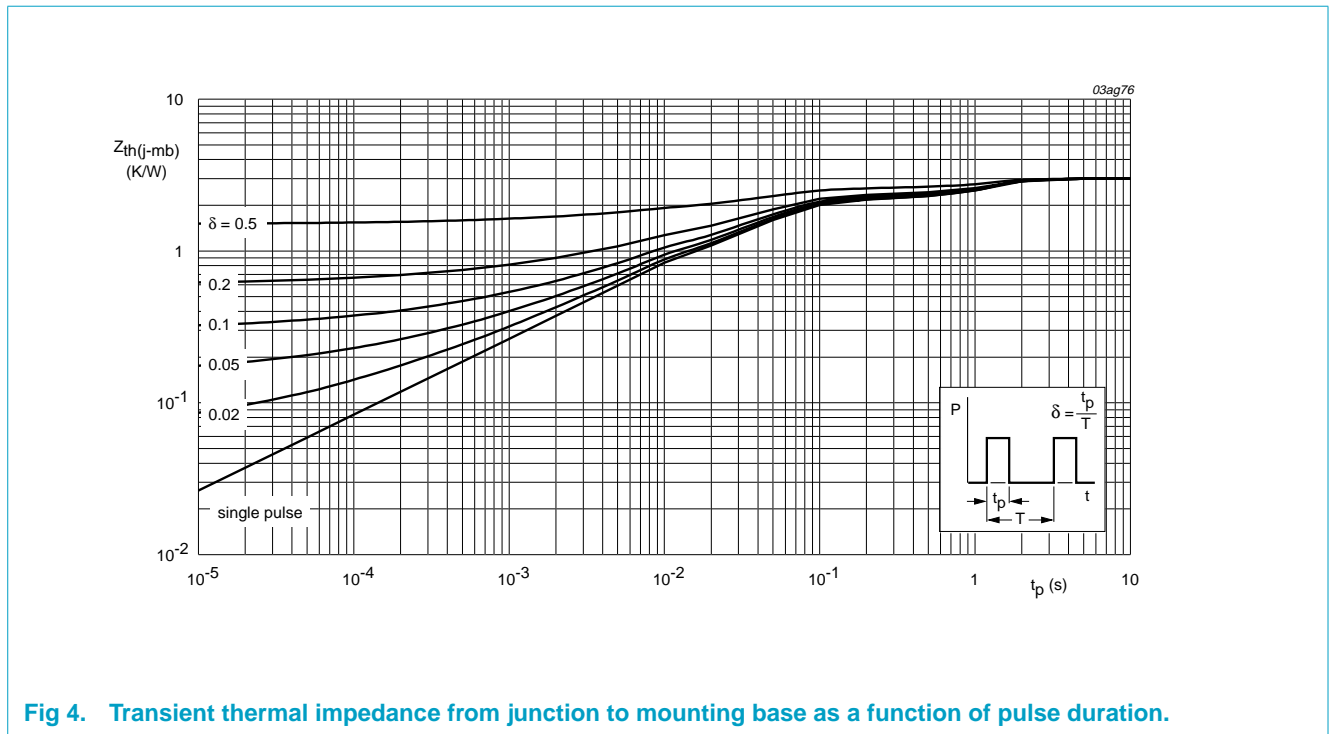
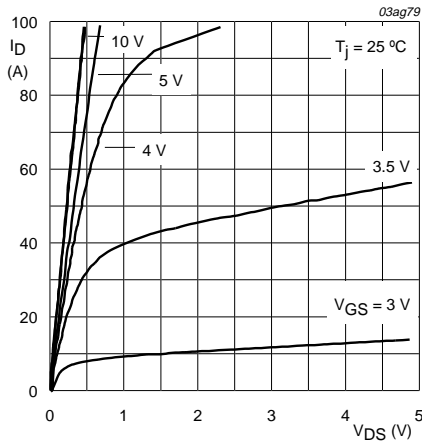


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration.

8. Characteristics

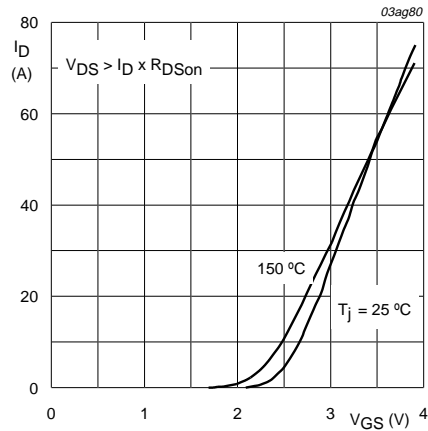
Table 5: Characteristics
T_j = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
V _{(BR)DSS}	drain-source breakdown voltage	I _D = 10 mA; V _{GS} = 0 V	30	-	-	V
V _{GS(th)}	gate-source threshold voltage	I _D = 1 mA; V _{DS} = V _{GS} ; Figure 9	1	1.9	2.5	V
I _{DSS}	drain-source leakage current	V _{DS} = 30 V; V _{GS} = 0 V	-	-	1	μA
I _{GSS}	gate-source leakage current	V _{GS} = ±16 V; V _{DS} = 0 V	-	0.1	10	μA
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 25 A; Figure 7 and 8	-	3.2	3.7	mΩ
		V _{GS} = 4.5 V; I _D = 25 A; Figure 8	-	5.5	7.3	mΩ
Dynamic characteristics						
g _{fs}	forward transconductance	V _{DS} = 10 V; I _D = 25 A; Figure 11	39	55	-	S
Q _{g(tot)}	total gate charge	I _D = 50 A; V _{DD} = 10 V; V _{GS} = 10 V; Figure 14	-	75	-	nC
Q _{gs}	gate-source charge		-	16	-	nC
Q _{gd}	gate-drain (Miller) charge		-	14	-	nC
C _{iss}	input capacitance	V _{GS} = 0 V; V _{DS} = 10 V; f = 1 MHz; Figure 12	-	4750	-	pF
C _{oss}	output capacitance		-	1160	-	pF
C _{rss}	reverse transfer capacitance		-	630	-	pF
t _{d(on)}	turn-on delay time	V _{DD} = 10 V; I _D = 25 A; V _{GS} = 10 V; R _G = 4.7 Ω	-	25	-	ns
t _r	rise time		-	50	-	ns
t _{d(off)}	turn-off delay time		-	90	-	ns
t _f	fall time		-	26	-	ns
Source-drain (reverse) diode						
V _{SD}	source-drain (diode forward) voltage	I _S = 50 A; V _{GS} = 0 V; Figure 13	-	0.85	0.98	V
t _{rr}	reverse recovery time	I _S = 50 A; dI _S /dt = -50 A/μs; V _{GS} = 0 V	-	60	-	ns



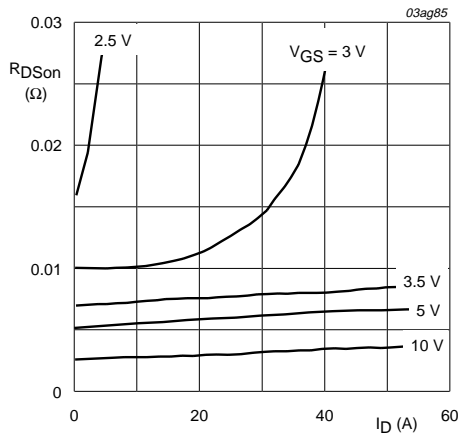
$T_j = 25\text{ }^\circ\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



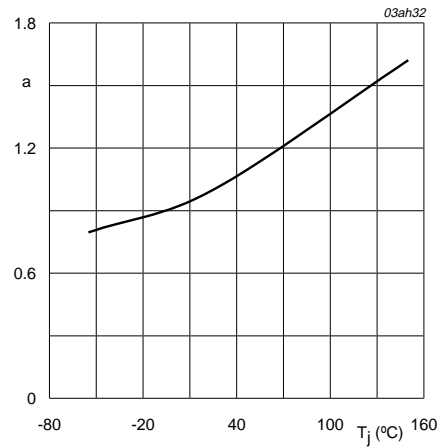
$T_j = 25\text{ }^\circ\text{C}$ and $150\text{ }^\circ\text{C}$; $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



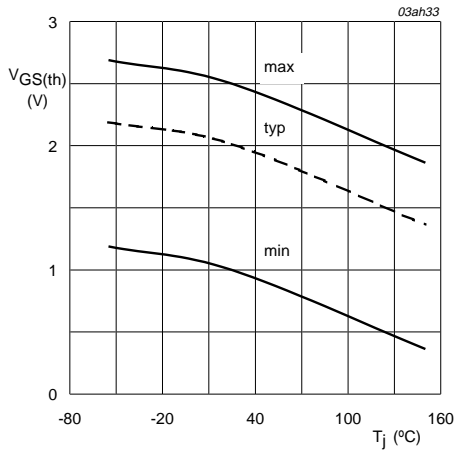
$T_j = 25\text{ }^\circ\text{C}$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



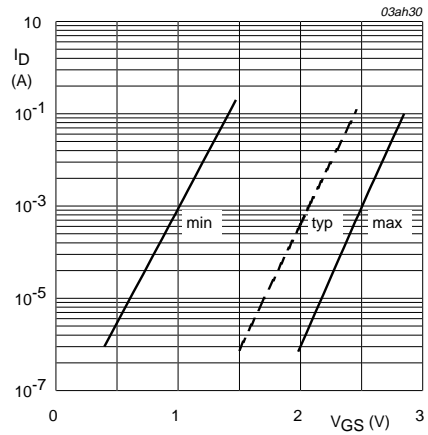
$$a = \frac{R_{DSon}}{R_{DSon(25^\circ\text{C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.



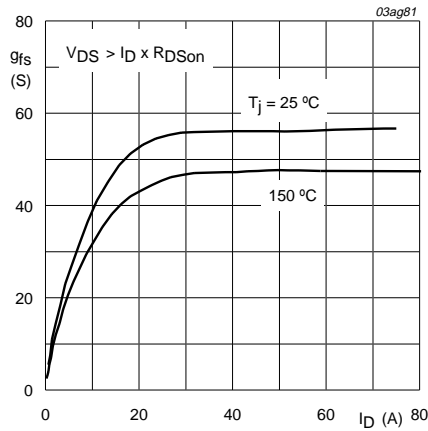
$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature



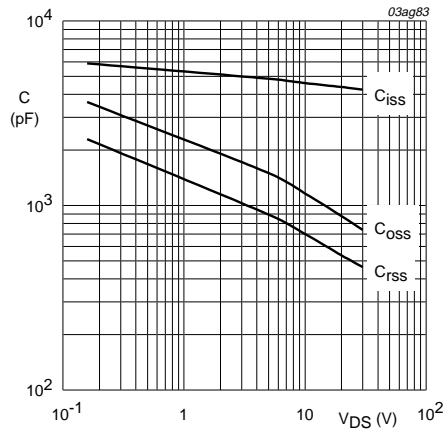
$T_j = 25 \text{ }^{\circ}C$

Fig 10. Sub-threshold drain current as a function of gate-source voltage.



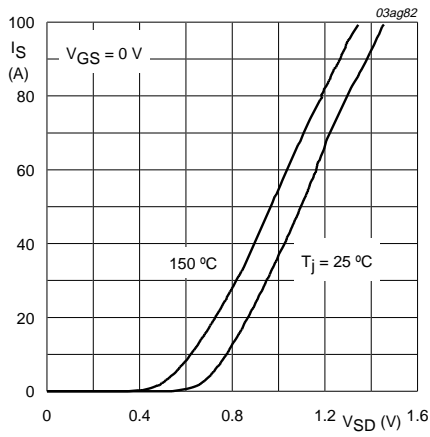
$T_j = 25 \text{ }^{\circ}C$ and $150 \text{ }^{\circ}C$; $V_{DS} > I_D \times R_{DS(on)}$

Fig 11. Forward transconductance as a function of drain current; typical values.



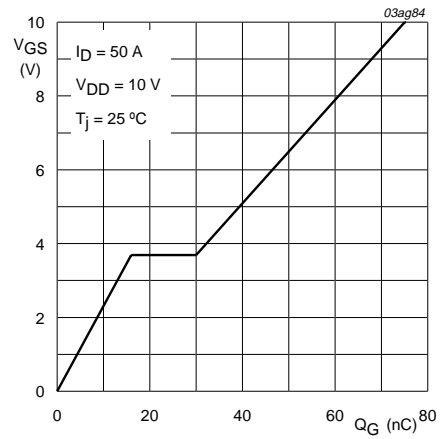
$V_{GS} = 0 \text{ V}$; $f = 1 \text{ MHz}$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.



$T_j = 25$ °C and 150 °C; $V_{GS} = 0$ V

Fig 13. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.



$T_j = 25$ °C; $I_D = 50$ A; $V_{DD} = 10$ V

Fig 14. Gate-source voltage as a function of gate charge; typical values.

9. Package outline

Plastic single-ended surface mounted package (LFPAK); 4 leads

SOT669

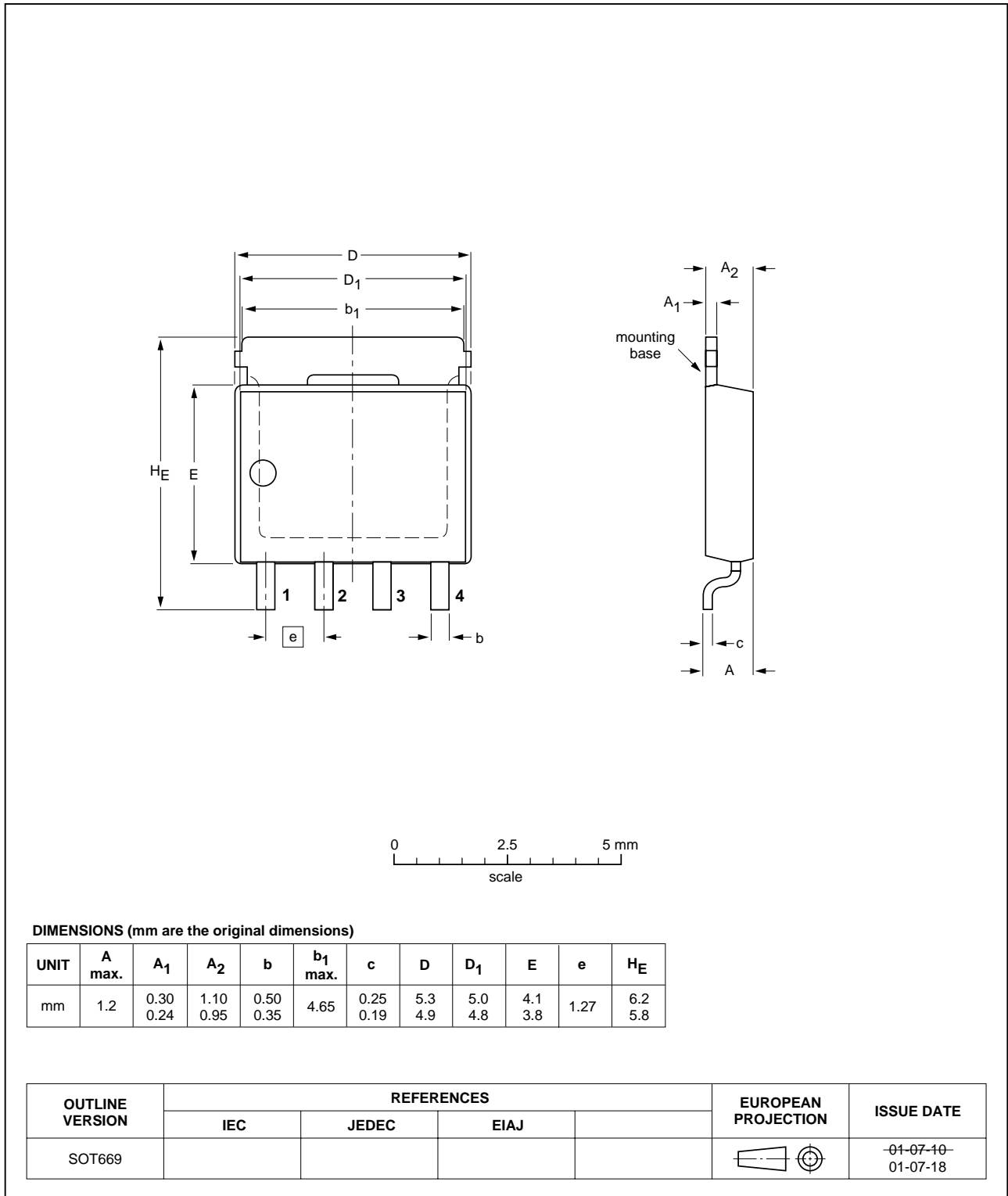


Fig 15. SOT669 (LFPAK).

10. Revision history

Table 6: Revision history

Rev	Date	CPCN	Description
1	20020207		Product data; initial version

11. Data sheet status

Data sheet status ^[1]	Product status ^[2]	Definition
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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Fax: +31 40 27 24825

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Date of release: 7 February 2002

Document order number: 9397 750 09395



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